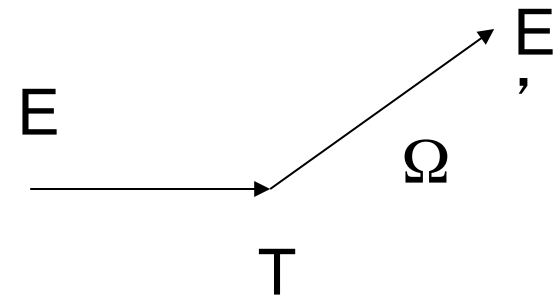


Differential cross sections

σ depends on the incident particle energy and the target material



$$\sigma(E) = \int dE' \sigma(E, E') = \int d\Omega \sigma(E, \Theta, \Phi) = \int dE' \int d\Omega \sigma(E, E', \Theta, \Phi)$$

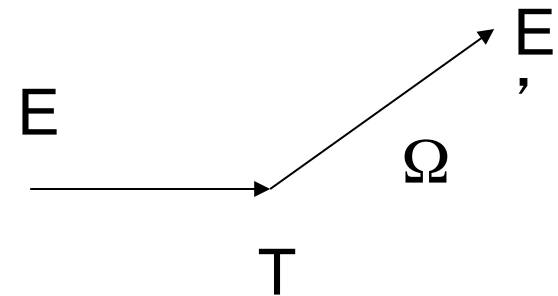
Simulation process

Simulation steps

- Determination of μ

$$\mu(E) = n \int dE' \int d\Omega \sigma(E, E', \Theta, \Phi)$$

$$n = \frac{\rho}{A} N_A$$



Simulation process

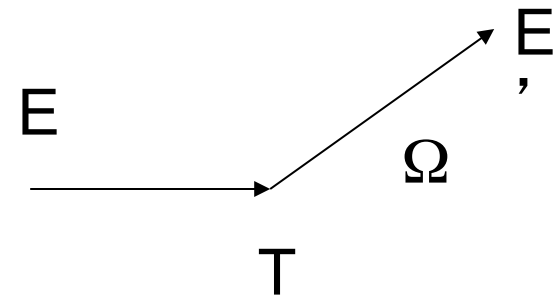
Simulation steps (cont.)

- Step length sampling

$$s = -\frac{1}{\mu(E)} \log(1 - r)$$

- Particle is displaced

$$\vec{x} = \vec{x}_0 + \vec{u}_0 s$$

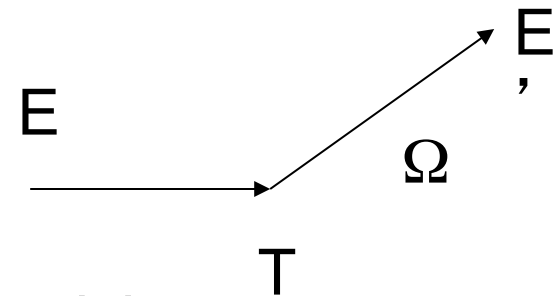


Simulation process

Simulation steps (cont.)

- Sampling of the particle energy after collision E'

$$m(E, E') = \int d\Omega p(E, E', \Theta, \Phi)$$



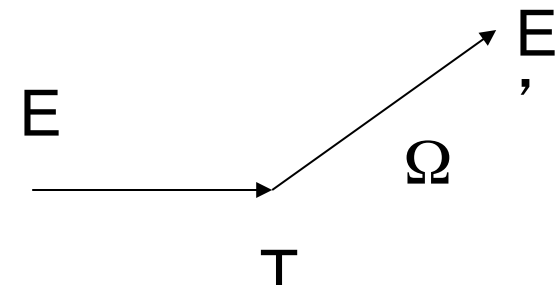
- Sampling of particle direction after collision

$$p(E, \Theta, \Phi | E') = \frac{p(E, E', \Theta, \Phi)}{m(E, E')}$$

Simulation process

Simulation steps (cont.)

- Particle direction is rotated



$$\mathcal{R}(\{\vec{x}_0, \vec{u}_0\}, \Theta, \Phi) = \{\vec{x}_0, \mathcal{R}(\theta_0, \phi_0)\mathcal{R}(\Theta, \Phi)\mathcal{R}^{-1}(\theta_0, \phi_0)\vec{u}_0\} = \{\vec{x}_0, \vec{u}\}$$

Compounds and mixtures

Determination of attenuation coefficients in compounds and mixtures

$$\mu(E) = \sum_i n_i \sigma_i$$

n_i is the volumetric atomic density for the material with microscopic cross section σ_i .

Compounds and mixtures

Determination of attenuation coefficients according to the relative weight w_i of the element in question

$$\mu(E) = \sum_i \frac{\tilde{\rho}_i}{A_i} N_A \sigma_i = \sum_i \tilde{\rho}_i \left(\frac{\mu_i}{\rho_i} \right) = \rho \sum_i w_i \left(\frac{\mu_i}{\rho_i} \right)$$

$\tilde{\rho}_i$ is the actual density of the i -th element in the compound
 μ/ρ is the mass attenuation coefficient

$$\frac{\mu(E)}{\rho} = \sum_i w_i \left(\frac{\mu_i}{\rho_i} \right) \quad w_i = \tilde{\rho}_i / \rho$$

Attenuation coefficients for each interaction

For instance, a photon can undergo several competitive interaction processes (photo electric effect, Compton scattering, pair production, etc.)

The total attenuation coefficient is determined as

$$\mu(E) = \sum_i \mu_i(E)$$

where i runs for all kind of possible processes

Attenuation coefficients for each interaction

Interaction probability per unit pathlength

$$p(z) = \sum_i p_i(z) = \sum_i \mu_i(E) e^{-z\mu(E)} = \sum_i \mu_i(E) p_s(z)$$

Fractional probability for i-th event

$$P_i = \frac{p_i(z)}{p(z)} = \frac{\mu_i(E)}{\mu(E)}$$

Attenuation coefficients for each interaction

Sampling of the current event

- A random number r is generated

$$r \leq \mu_1(E)/\mu(E) \quad \text{Event type 1 occurs}$$

- Else

$$r \leq [\mu_1(E) + \mu_2(E)]/\mu(E) \quad \text{Event type 2 occurs 2}$$

- Else

$$r \leq [\mu_1(E) + \mu_2(E) + \mu_3(E)]/\mu(E) \quad \text{Event type 3 occurs}$$

And so on...

Interaction models

Isotropic scattering

$$p(\Theta, \Phi) d\Theta d\Phi = \frac{1}{4\pi} \sin \Theta d\Theta d\Phi$$

Expressions for sampling

$$\begin{aligned}\cos \Theta &= 1 - 2r_1 \\ \Phi &= 2\pi r_2\end{aligned}$$

Interaction models

Semi-isotropic scattering

$$p(\Theta, \Phi) d\Theta d\Phi = \frac{1}{4\pi}(1 + a \cos \Theta) \sin \Theta d\Theta d\Phi$$

Expression for sampling

$$\begin{aligned}\cos \Theta &= \frac{2 - a - 4r_1}{1 + \sqrt{1 - a(2 - a - 4r_1)}} \\ \Phi &= 2\pi r_2\end{aligned}$$

Interaction models

Small angle Rutherford scattering

$$p(\Theta, \Phi) d\Theta d\Phi = \frac{2a}{\pi} \frac{\Theta d\Theta d\Phi}{(\Theta^2 + 2a)^2} \quad 0 \leq a < \infty, 0 \leq \Theta < \infty$$

Expressions for sampling

$$\begin{aligned}\Theta &= \sqrt{\frac{2ar}{1-r}} \\ \Phi &= 2\pi r_2\end{aligned}$$

If $\theta > \pi$, the angle is rejected and the process is repeated